Notice of References Cited Application/Control No. 10/734,109 Examiner HIEU T. VO Applicant(s)/Patent Under Reexamination JALIWALA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,102,009 A	08-2000	Nishiyama, Yasuhiro	701/105
*	В	US-6,360,161 B1	03-2002	Francis et al.	701/115
*	С	US-6,363,314 B1	03-2002	Hafner et al.	701/104
*	D	US-6,409,094 B2	06-2002	Tojo et al.	239/5
*	Е	US-6,549,843 B1	04-2003	Koerner, Scott A.	701/104
*	F	US-6,705,294 B2	03-2004	Shinogle, Ronald	73/119A
*	G	US-6,801,847 B2	10-2004	Jaliwala et al.	701/104
	Н	US-		·	
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	Total							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р							
	Q							
	R							
	s							
	Т							

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	х	

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